## Search Notes



Application/Control No.

Applicant(s)/Patent Under

Reexamination

CHANG, CHIEN-JEN

Examiner

10764241

Art Unit

Scott Jr, Thomas E

2609

## **SEARCHED**

Class	Subclass	Date	Examiner
345	89,589-605	3/20/2007	TESJR
349	142	3/16/2007	TESJR

## **SEARCH NOTES**

Search Notes	Date	Examiner
Attached EAST search and inventor search	3/19/2007	TESJR

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner